Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/772,515	SHUJI HAYASHI	•
Examiner	Art Unit	
Carramah J. Quiett	2622	

	SEAR	CHED	
Class	Subclass	Date	Examiner
348	207.2,239, 231.3, 231.6, 231.9	3/17/2007	CJQ
396	2	3/17/2007	CJQ

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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DATE	
	EXMR
17/2007	CJQ
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